

<b>Notice of References Cited</b>		Application/Control No. 10/816,168	Applicant(s)/Patent Under Reexamination NAKADA ET AL.	
		Examiner Edna Wong	4231056 Art Unit 1795	Page 1 of 1

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*	B	US-6,989,084	01-2006	Tench et al.	204/275.1
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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